fortiss

Extending the risk-based approach for Artificial Intelligence

Why and how to rethink the risk-based approach for new technologies (AI/ML/NN)



NOT IF, BUT HOW

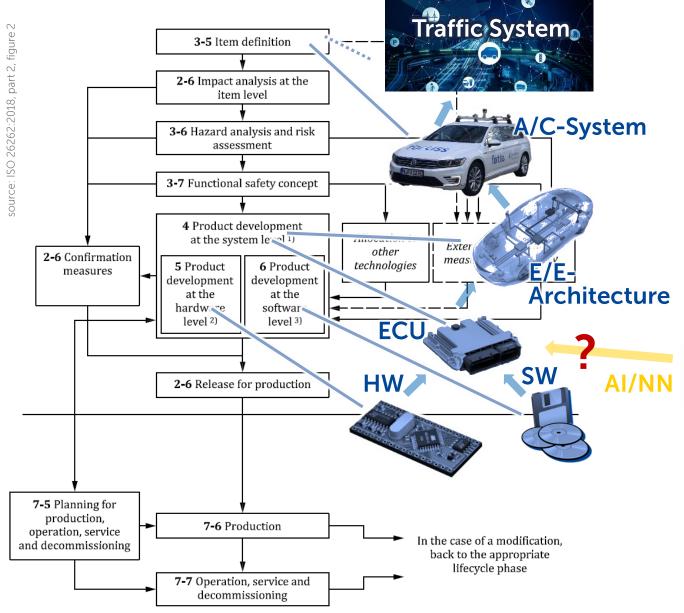
compelx AI-based systems safety in development & operation

Motivation

And this is your Machine Learning system? Yup! You pour data into this big pile of linear algebra, then collect the answers on the other side. What if the answers are wrong? Just stir the pile until they start looking right. evidential safe? ANSWERS

The risk-based approach and AI/NN

5



risk-based approach

▶ Current standardization

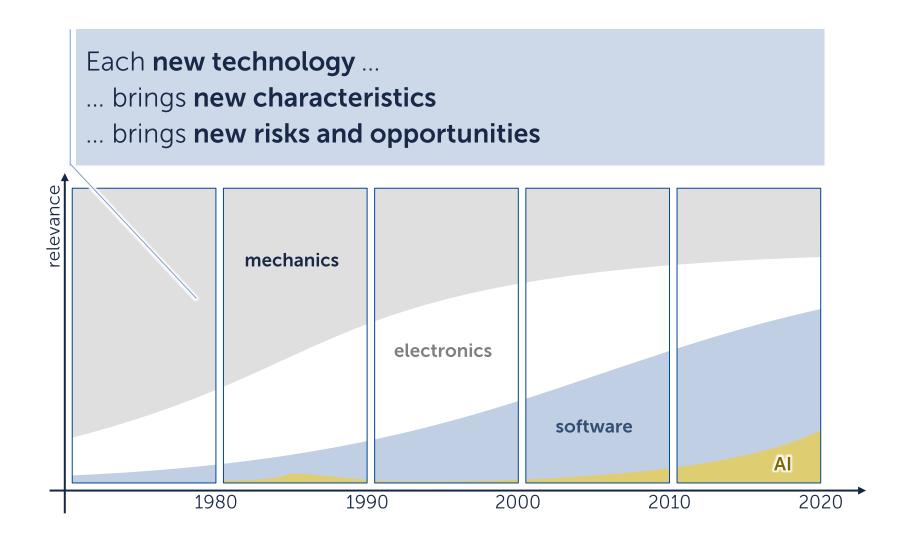
- ISO 26262: risks from systematic failures and random hardware failures
- ISO 21448: risks from intended function (SOTIF)
- ISO 21434: risks from cybersecurity aspects



▶ To be understood

- Characteristics of AI/NN
- Failure modes
- Contribution to safety goal violation
- Integration into risk-based approach

Each new technology needs a suitable/new approach



► AI/NN is a new technology that takes specification and comes up with an implementation strategy

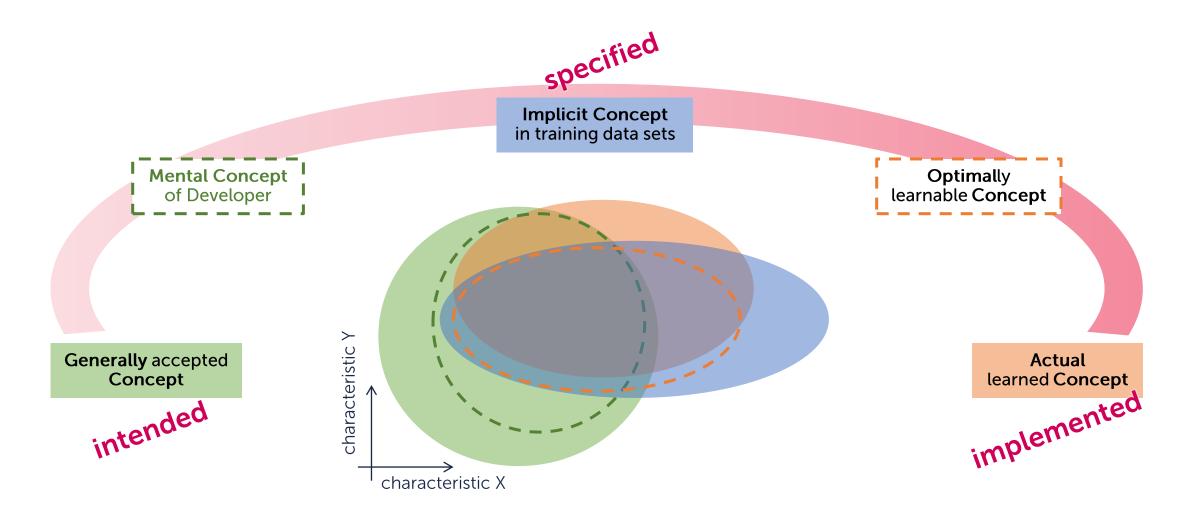
Mapping failures to technology specific measures

Requirements on platform (HW and classical SW)

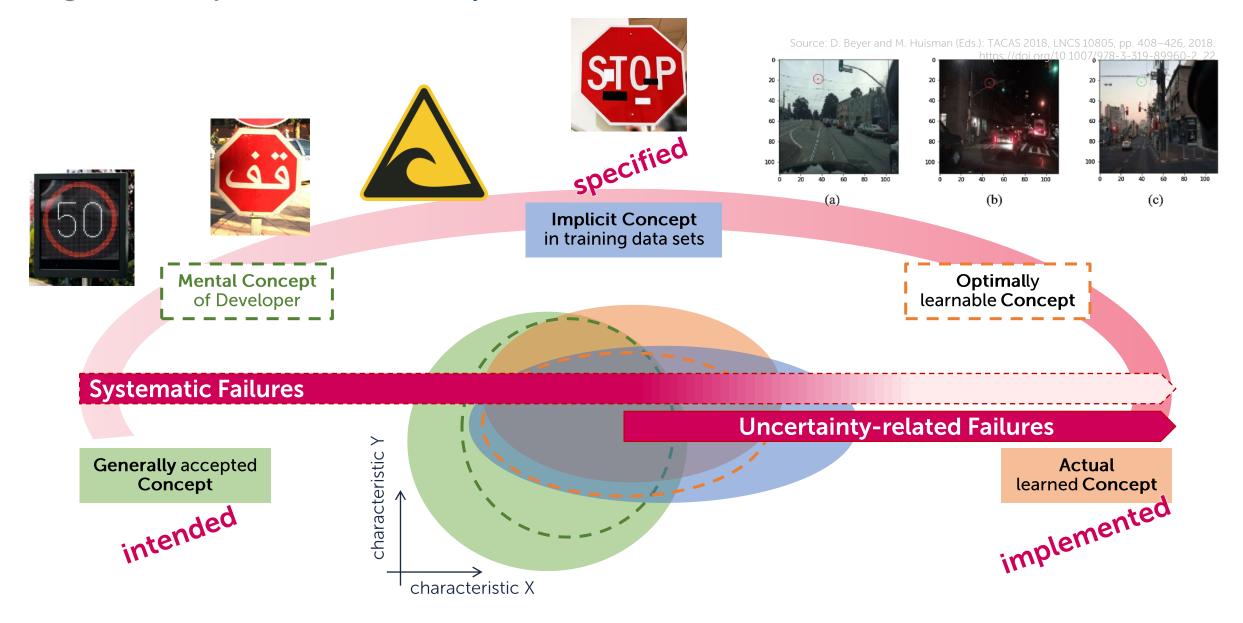
type of failure	measures	measures for HW	measures for SW	measures for AI/NN
systematic	Qualitative Requirements: Culture, Experts, QS Process, Design, Methods & Measures	systematic capability (TPL ASIL)	systematic capability (TPL ASIL)	?
random	Quantitative Requirements: Metrics and Thresholds	SPFM, LFM, DC, FIT – (ASIL rel. target)	/	?
more?	?	?	?	?

artifacts become evidences within the argumentation (e.g. GSN) of the safety case (trustworthiness assurance case)

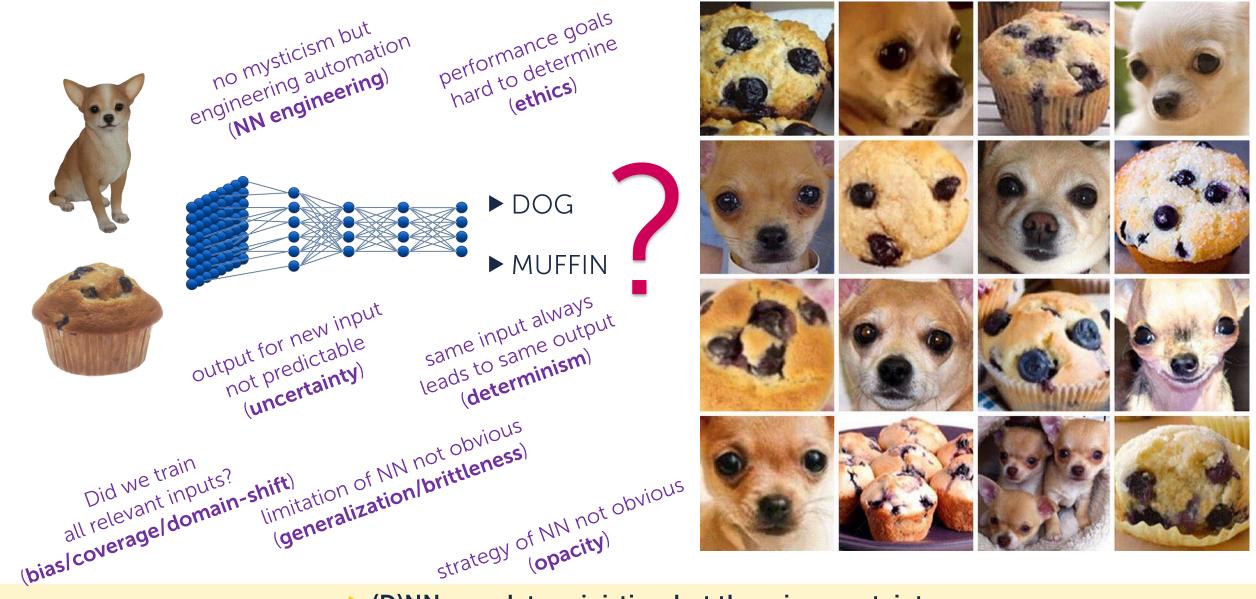
Insights on Deep Neural Networks - phases and activities



Insights on Deep Neural Networks - problems



Un-fevered facts on DNNs



► (D)NNs are deterministic ~ but there is uncertainty

Mapping failures to technology specific measures (2)

Requirements on platform (HW and classical SW)

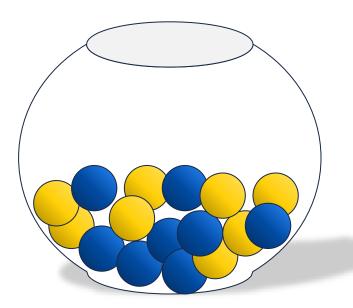
type of failure	measures	measures for HW	measures for SW	measures for Al/NN
systematic	Qualitative Requirements: Culture, Experts, QS Process, Design, Methods & Measures	systematic capability (TPL ASIL)	systematic capability (TPL ASIL)	?
random	Quantitative Requirements: Metrics and Thresholds	SPFM, LFM, DC, FIT – (ASIL rel. target)	/	/
uncertainty- related	Structured Approach: Metrics, References, Measures and Argumentation	/	/	?

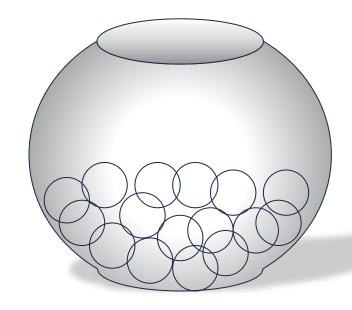
artifacts become evidences within the argumentation (e.g. GSN) of the safety case (trustworthiness assurance case)

Uncertainty thought experiment

probabilism (risk)

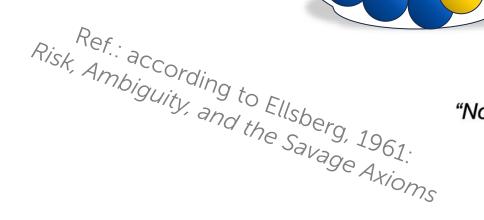
unknown result but information about likelihood





no information (uncertainty)

unknown result and unknown likelihood



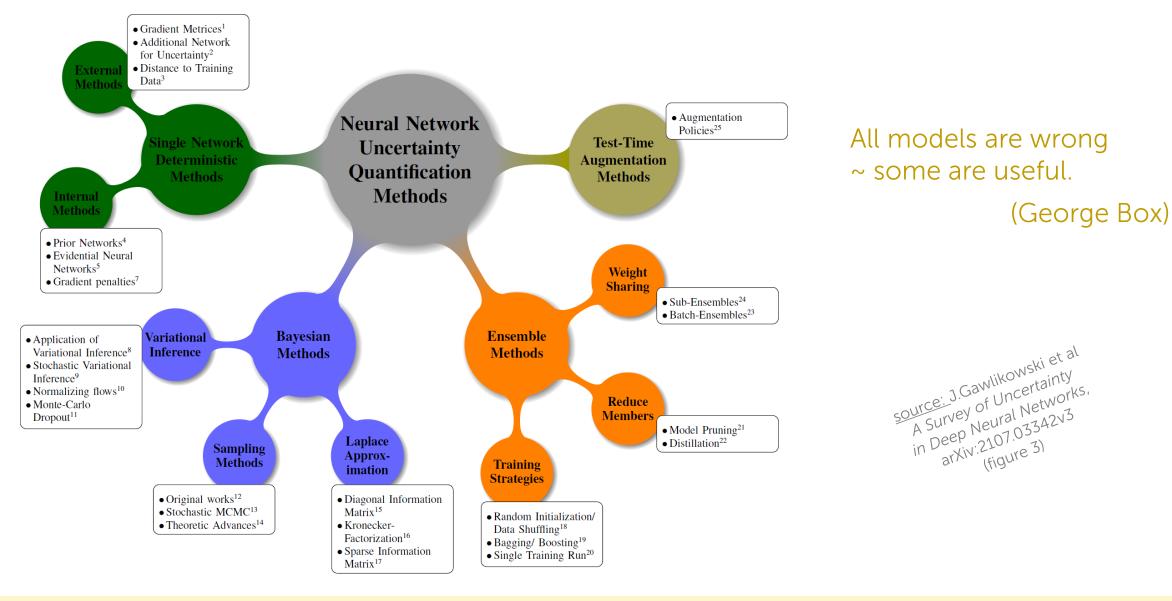
"Not knowing the chance of mutually exclusive events and knowing the chance to be equal are two quite different states of knowledge"

Ronald Fisher (1890-1962)



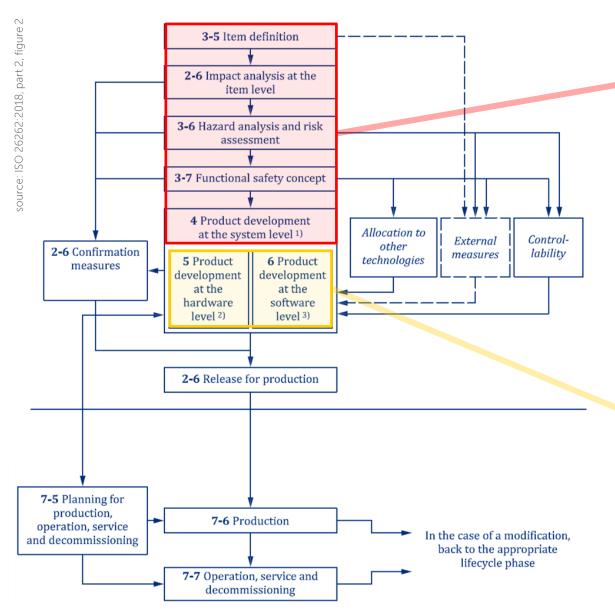
► AI/NN as new technology induces uncertainty-related effects (risks)

Quantifying uncertainty in NNs - research



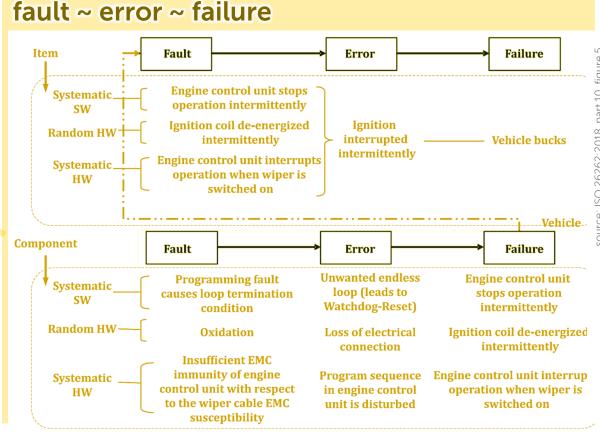
Quantifying the uncertainty in NNs is a matter of research

Quantifying uncertainty in NNs – available approach

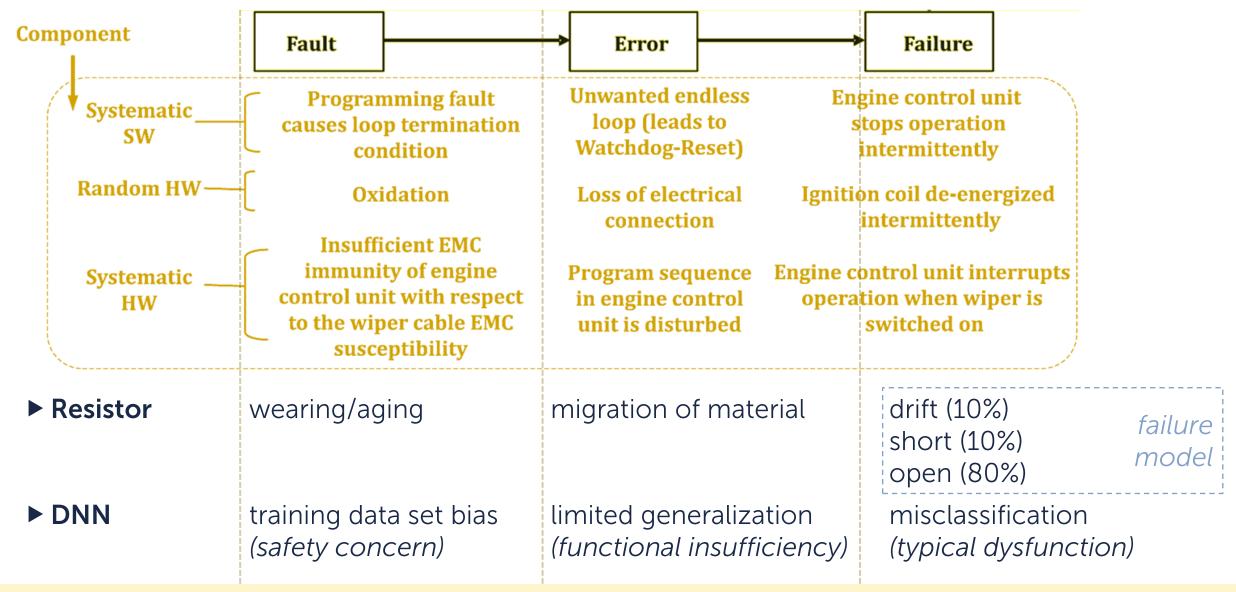


traceability

- Hazard Analysis & Risk Assessment (HARA)
- Functional Safety Concept (FSC)
- Safety Functions (+ attributes and requirements)

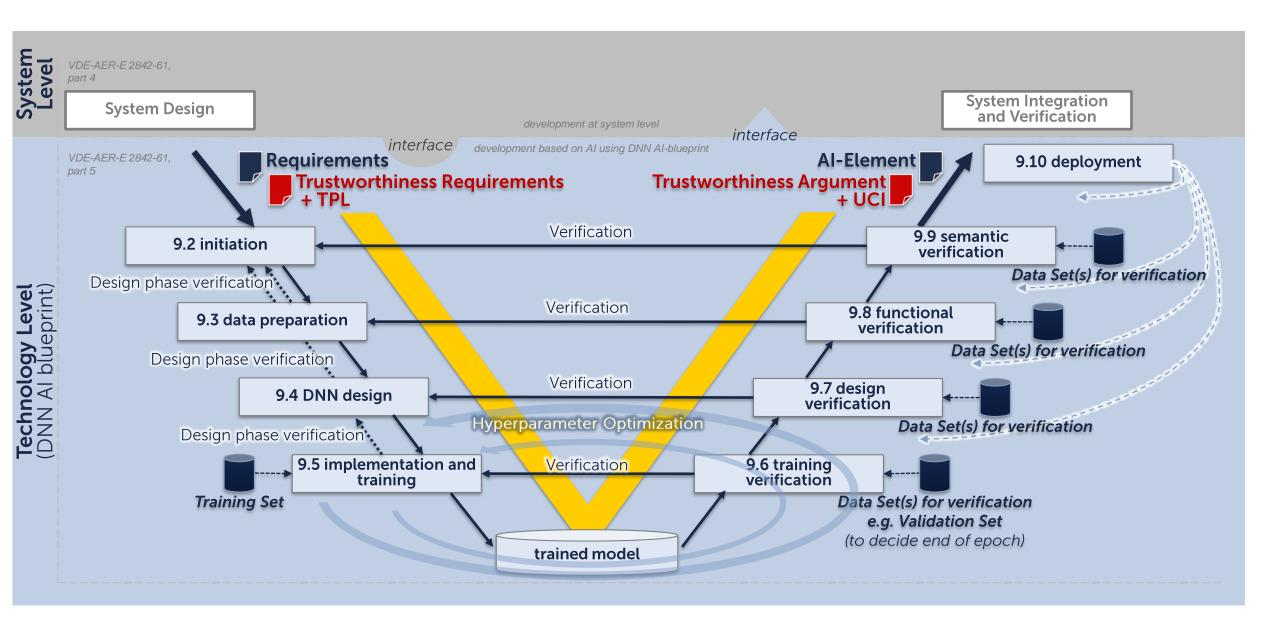


Quantifying uncertainty in NNs - fault ~ error ~ failure

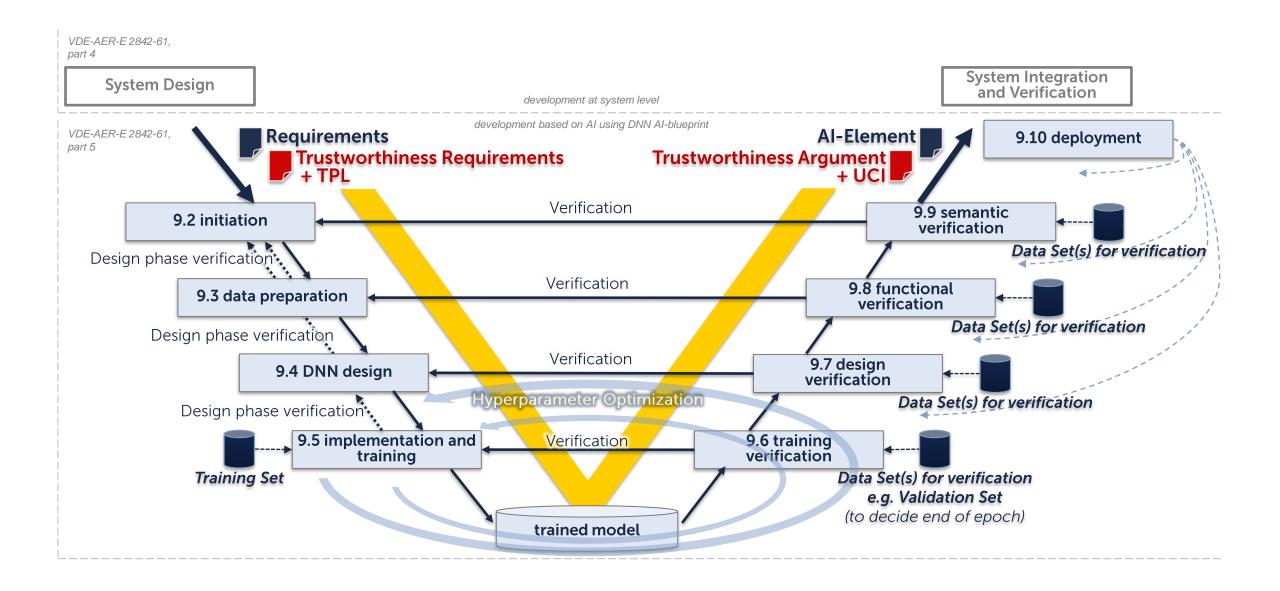


► Any **structured approach** to a failure model of AI/NN?

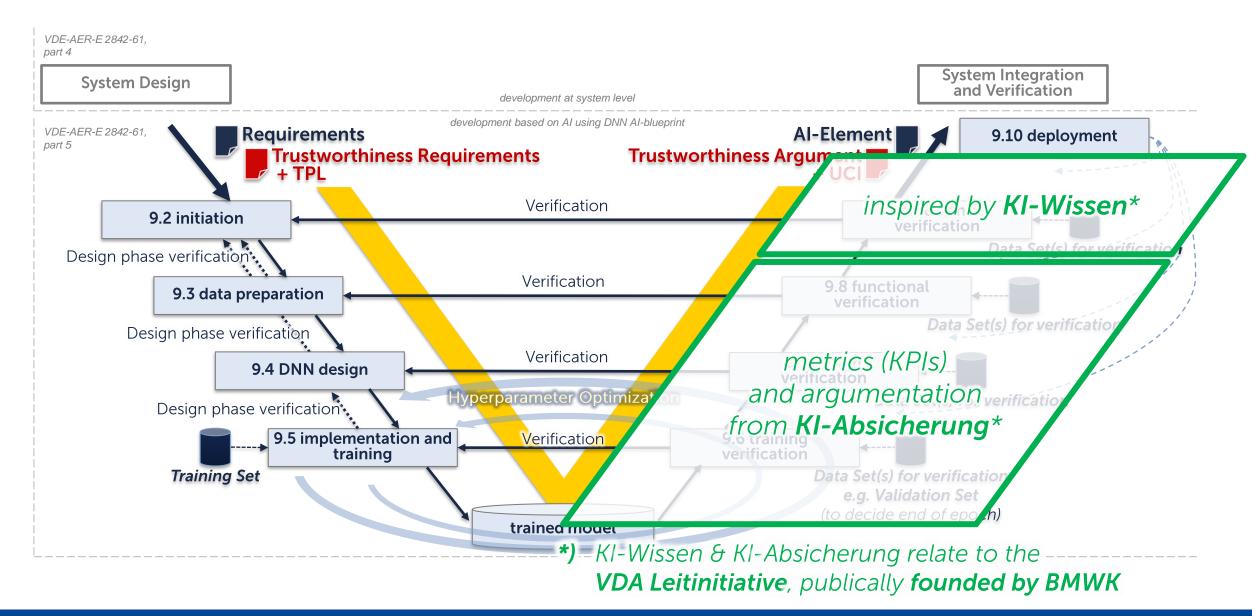
Structured development of DNNs - DNN AI blueprint acc. to VDE-AR-E 2842-61



Structured development of DNNs - DNN AI blueprint acc. to VDE-AR-E 2842-61



Structured development of DNNs – based on latest research & VDA Leitinitiative



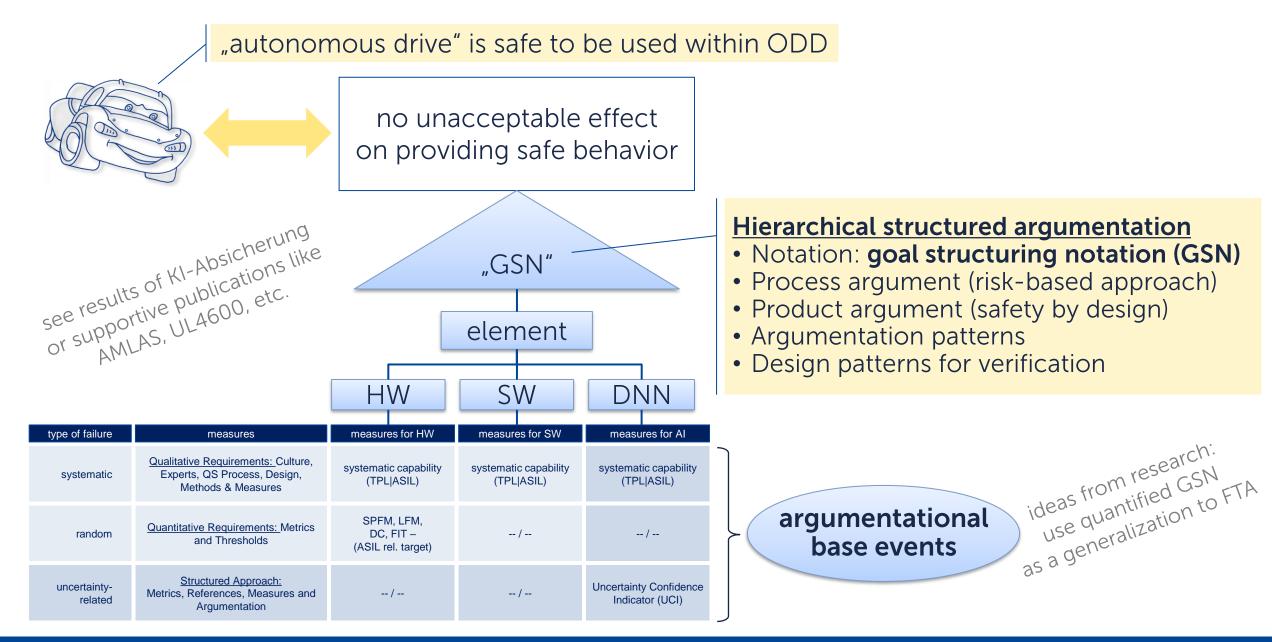
Mapping failures to technology specific measures (final)

Requirements on platform (HW and classical SW)

type of failure	measures	measures for HW	measures for SW	measures for Al
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random	Quantitative Requirements: Metrics and Thresholds	SPFM, LFM, DC, FIT – (ASIL rel. target)	/	/
uncertainty- related	Structured Approach: Metrics, References, Measures and Argumentation	/	/	Uncertainty Confidence Indicator (UCI)

artifacts become evidences within the argumentation (e.g. GSN) of the safety case (trustworthiness assurance case)

The assurance case integrates all evidences into



PRO (mise)

CONTRA (indication)

new technology

implicit requirements

shorter time to market

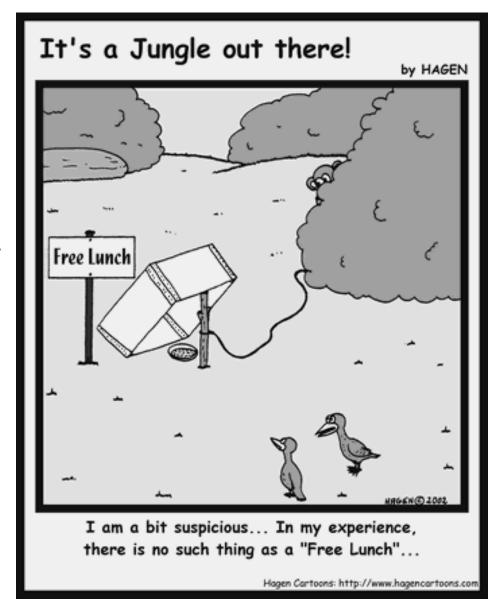
enable complex automation

No-Free-Lunch Theorem:

$$\sum_f P(h_m^y|f,m,a_1) = \sum_f P(h_m^y|f,m,a_2).$$

Reality: no free lunch!

Free Lunch?



PRO (mise)

CONTRA (indication)

new technology

implicit requirements

shorter time to market

enable complex automation

uncertainty

- ► AI/ML/NN are new technologies
 - no mysticism,
 - but automation engineering with
 - new characteristics
- ▶ There is no free lunch

PRO (mise)

CONTRA (indication)

new technology

implicit requirements

shorter time to market

enable complex automation

certification unclear

uncertainty

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PRO (mise)

CONTRA (indication)

new technology

implicit requirements

shorter time to market

enable complex automation

Need new type of verification

> certification unclear

uncertainty

► AI/ML/NN are new technologies

- no mysticism,
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- ▶ There is no free lunch

PRO (mise)

CONTRA (indication)

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implicit requirements

shorter time to market

enable complex automation

not fully understood

need new type of verification

> certification unclear

uncertainty

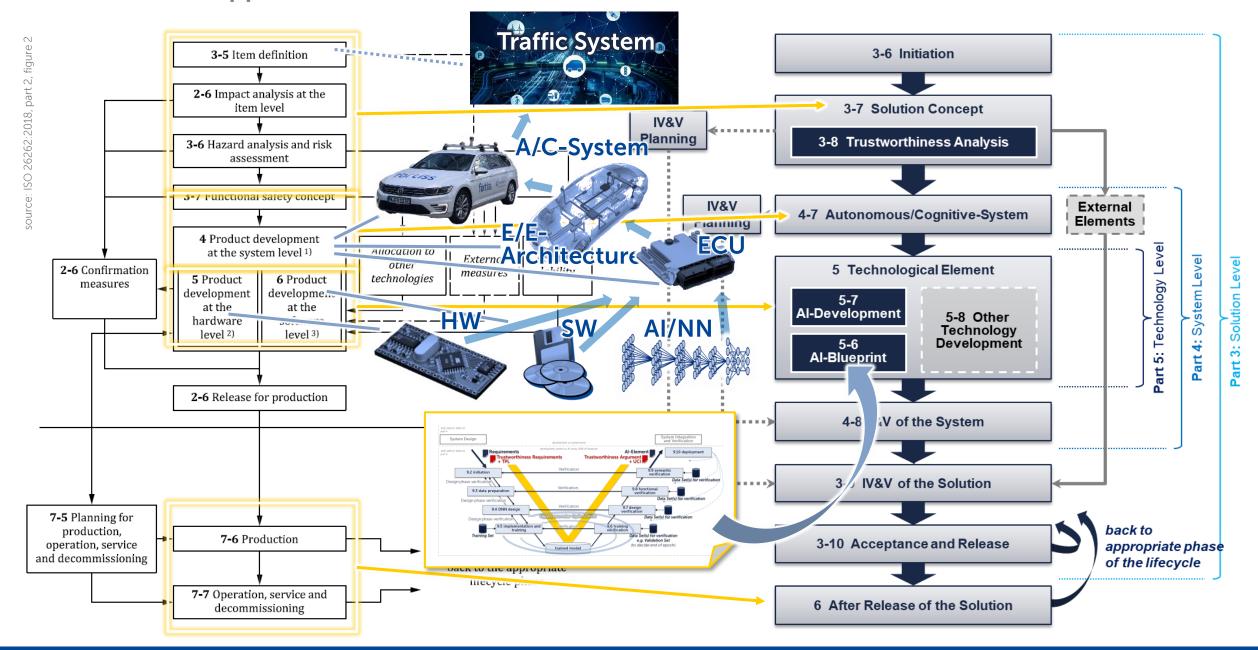
► AI/ML/NN are new technologies

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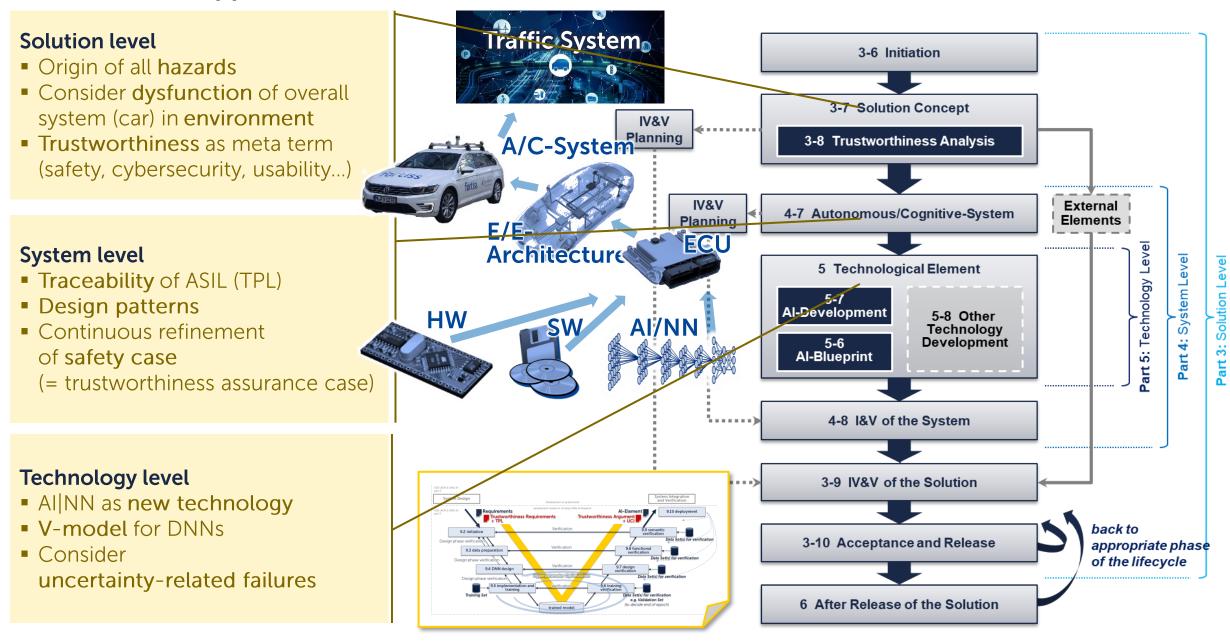
▶ There is no free lunch New technologies need ...

- new development methods
- new processes
- new standards
- new risk management
- new governance structures
- new certification & maturity
- suitable Al strategy

The risk-based approach and AI/NN



The risk-based approach and AI/NN



Trustworthy Autonomous/Cognitive Systems (A/C-System)

independent from industry & application

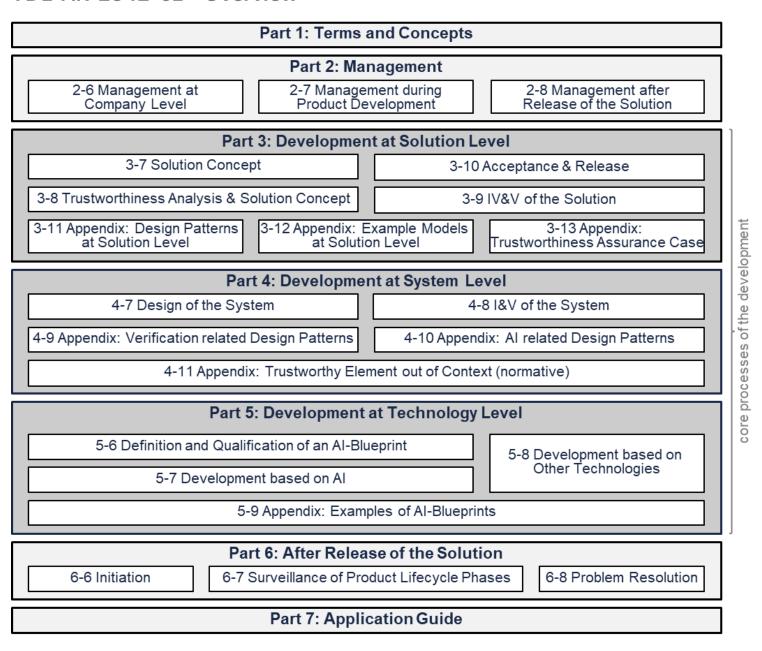
separate ethical/moral aspects from technology risk-based approach along lifecycle complex system-of-systems Performance und Trustworthiness anvironme.

Other objects & systems

Stakeholders **Solution Level System Level Technology Level (AI)** VDE-AR-E 2842-61

inspired by IEC 61508 & ISO 26262 (aware of other working groups, e.g. ISO/IEC JTC 1/ SC 42)

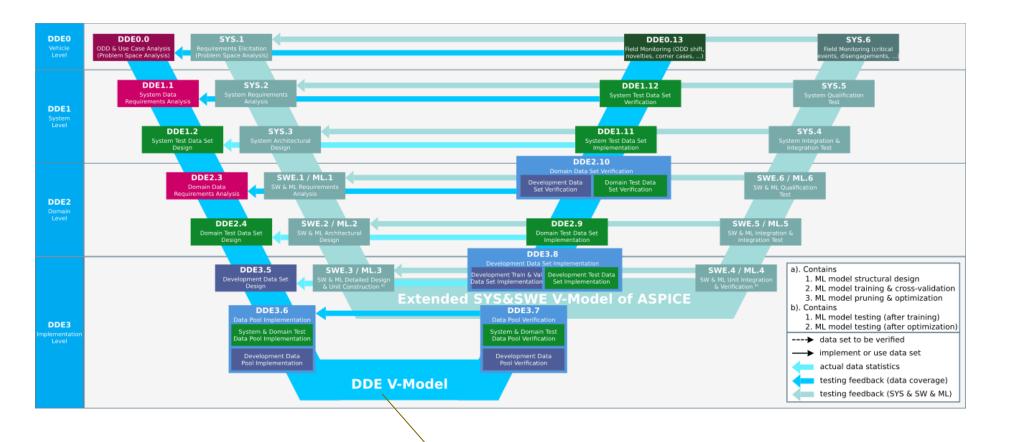
VDE-AR-2842-61 - Overview



VDE-AR-E 2842-61 comprises of 6+x parts:

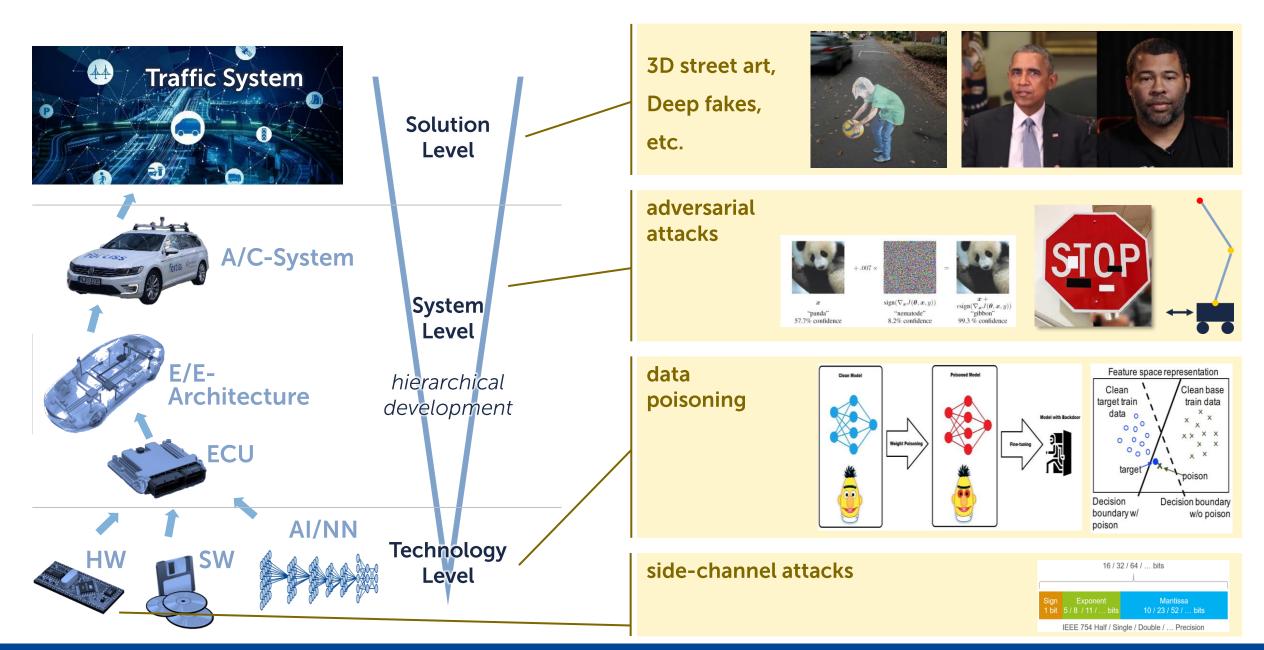
- 1) Terms and Concepts ✓
- 2) Management ✓
- 3) Solution Level (✓)
- 4) System Level Q3-2022
- 5) Technology Level (✓)
- 6) After SOP ✓
- 7) Application guides (in preparation)

RELATED: Data Driven Engineering

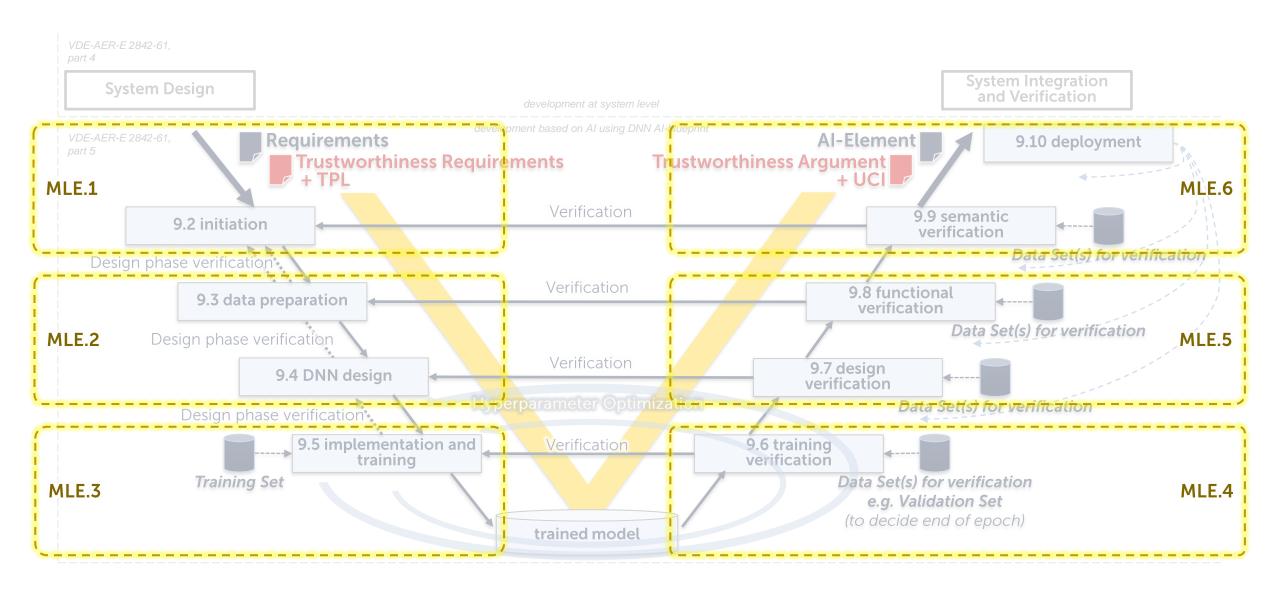


Use Data Driven Engineering (DDE) to prepare data as a consistent approach over all levels of development abstraction

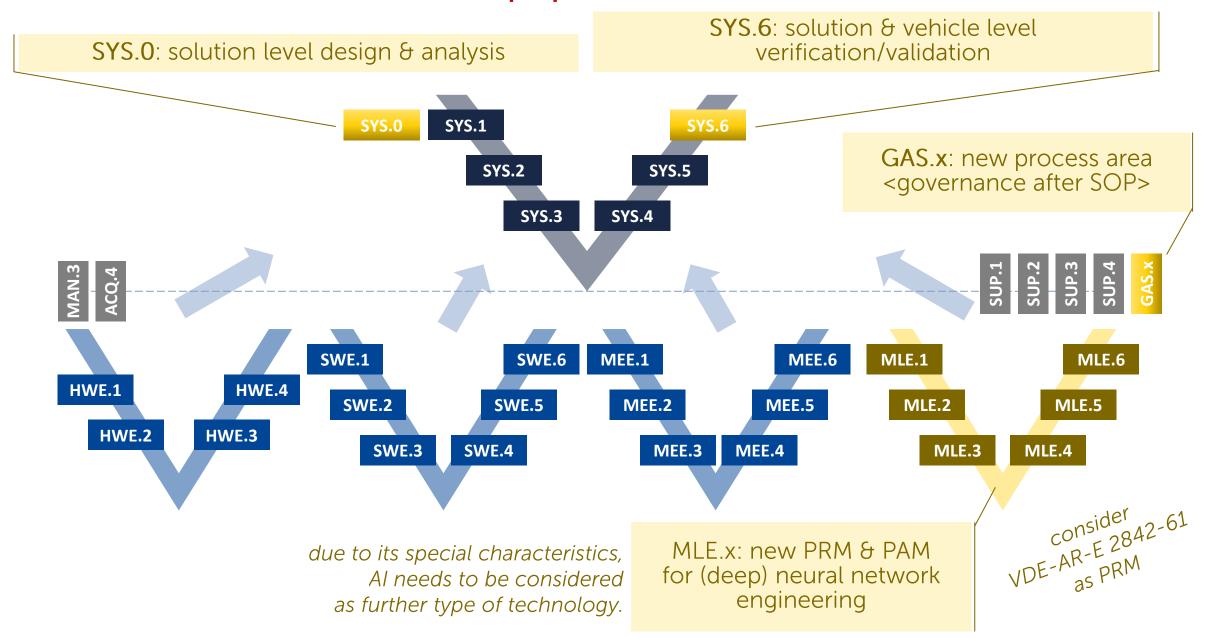
RELATED: Cybersecurity for Al



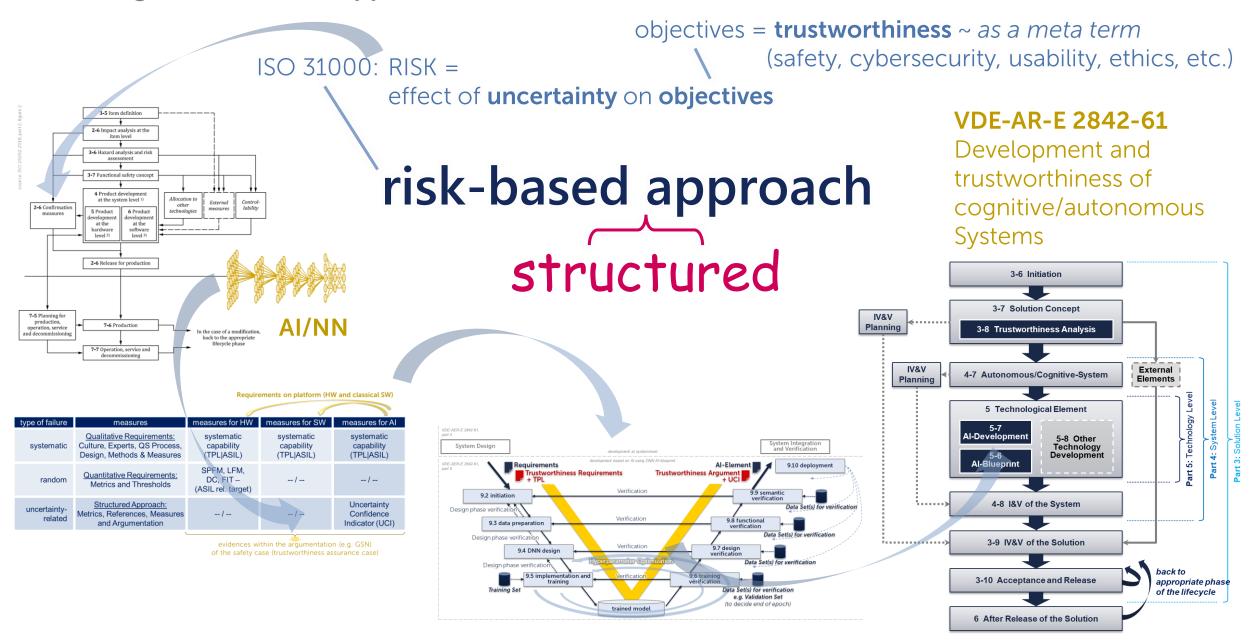
RELATED: VDE-AR-E 2842-61 DNN AI blueprint inspires a PRM for KI ASPICE



RELATED: SPICE and ASPICE extension (proposal!)



Extending the risk-based approach for AI/NN



Extending the risk-based approach for Al

Contact us ... to contribute or ... to test drive & projects





Presentation by fortiss & cogitron



As a computer scientist **Dr. Henrik J. Putzer** received his grade at the institute of Prof. Onken and Prof. Dickmanns at the University of the German armed forces in Munich with research on human centered, Al based assistants. After several successful industrial projects focusing on overall design, safety, security and process development cross industries he contributed to state of the art in E/E systems engineering. Among others he was core contributor to the ISO 26262 and currently holds a chair in der VDE DKE working group for the VDE-AR-E 2842-61. Currently he is the head of Trustworthy Autonomous Systems at the research institute fortiss and he is the CEO of cogitron, a consulting business on processes, embedded systems, safety & security and Artificial Intelligence.



MSc Katharina Kofend received her Master of Science in Geoinformatics (MSc) at Technical University Munich and specialized in explainable and interpretability of AI.

At fortiss she researches in the area of trustworthy Artificial Intelligence, verification of AI and assurance cases (including safety, security and related standardization).



Dr. Hans Herrmann completed his studies of mechanical engineering at the University of Hannover. At the University of Bonn, he researched simulation methods for coupled physical and chemical processes, concluding with a dissertation. As a consultant Dr. Herrmann contributed to process improvement and products development in the branches automotive and aerospace by accounting for the subjects embedded systems, system & software safety, and process design. Currently Dr. Herrmann is busy as consultant at cogitron GmbH and represents the field of embedded systems, safety, cybersecurity, and process consulting.

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